## 11th European Symposium on Semiconductor Detectors

## Wednesday, 10 June 2009

## Photon Science - XFEL - Main Auditorium (09:00 - 10:40)

time	[id] title	presenter
	[48] DEPFET Sensor with Signal Compression: a Large Format X-ray Imager with Mega-Frame Readout Capability for the European XFEL	PORRO, Matteo
09:20	[49] Challenges in chip design for the AGIPD detector	SHI, Xintian
09:40	[56] LPD silicon pixel detector for XFEL	SELLER, Paul
10:00	[90] Characterisation of an adaptive gain silicon microstrip readout chip.	MOZZANICA, Aldo
10:20	[50] Large Format Imaging Detectors for X-ray Free-Electron-Lasers	HARTMANN, Robert